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PATENT APPLICATION DOCKET NO.: 3243.1001-001

.1001-001 Jfw



THE UNITED STATES PATENT AND TRADEMARK OFFICE

Christina Lampe-Onnerud, Per Onnerud, Jie Shi, Sharon Dalton, Tomoyoshi Koizumi and Aisaku Nagai

Application No.:

10/073,674

Group Art Unit:

1752

Filed:

February 11, 2002

Examiner:

Hoa Van Le

Confirmation No.:

4577

Title:

[]

under 37 CFR 1.97(i):

(Filed after payment of issue fee)

GRADIENT CATHODE MATERIAL FOR LITHIUM RECHARGEABLE BATTERIES

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SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Mail Stop Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Alexar	ndria, VA 22313-1450
Sir:	
This I	nformation Disclosure Statement is submitted: under 37 CFR 1.129(a), or (First/Second submission after Final Rejection)
[X]	under 37 CFR 1.97(b), or (Within any one of the following time periods: three months of filing national application (other than a CPA) or date of entry of the national stage in an international application; or before the mailing date of a first office action on the merits in a non-provisional application, including a CPA, or a Request for Continued Examination).
[]	under 37 CFR 1.97(c) together with either: [] a Statement under 37 CFR 1.97(e), as checked below, or [] a \$180.00 fee under 37 CFR 1.17(p), or (After the 37 CFR 1.97(b) time period, but before final action or notice of allowance, whichever occurs first)
[]	under 37 CFR 1.97(d) together with: [] a Statement under 37 CFR 1.97(e), as checked below, and [] a \$180.00 fee under 37 CFR 1.17(p), or (Filed after final action or notice of allowance, whichever occurs first, but on or before payment of the issue fee)

Applicant requests that the IDS and cited reference(s) be placed in the application filewrapper.

Statem	ent Un	<u>der 37 C</u>	CFR 1.97(e)		
[]	Each item of information contained in this Information Disclosure Statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this Information Disclosure Statement; or				
[]	No item of information contained in this Information Disclosure Statement was cited in a communication from a foreign patent office in a counterpart foreign application, and, to the knowledge of the undersigned, after making reasonable inquiry, no item of information contained in the information disclosure statement was known to any individual designated in 37 CFR 1.56(c) more than three months prior to the filing of this Information Disclosure Statement.				
Statem	nent Un	<u>der 37 C</u>	(Patent Term Adjustment) Applies to original applications (other than design) filed on or after May 29, 2000		
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[X]	Enclos	sed here	with is form PTO-1449:		
	[X]	Copies	of the cited references AA, AP3-AQ3, AL4-AO4 and AR-AS are enclosed.		
		[]	Since this application was filed after June 30, 2003, copies of issued U.S. patents and published U.S. applications are not required and are not being provided.		
	[]	Applic	of the cited references are enclosed except those entered in prior application, U.S. ation No. [], to which priority under 35 U.S.C. 120 is claimed. [The earlier tion contains copies of the cited references.]		
	[]	The lis	ted references were cited in the enclosed International Search Report in a rpart foreign application.		
	[X]	The "c AL4-A	oncise explanation" requirement (non-English references) for references AP3 and O4 under 37 CFR 1.98(a)(3) is satisfied by:		
		[]	the explanation provided on the attached sheet.		
		[]	the explanation provided in the Specification.		
		[]	submission of the enclosed International Search Report.		
		[]	submission of the enclosed English-language version of a foreign Search Report and/or foreign Office Action.		
		[X]	the enclosed English language abstracts.		

Examiner's Initials					
		U.S. Patent Application No. [], by [inventor(s)], filed [], Docket No.: []
		U.S. Patent Application No. [], by [inventor(s)], filed [], Docket No.: []
		U.S. Patent Application No. [], by [inventor(s)], filed [], Docket No.: []
		Examiner	Date	_	
	[]	A copy of each above-cited app	plication, including the curre	nt claims, is enclosed	i .
	[]	A copy of each above-cited application of those entered in prior application 35 U.S.C. 120 is claimed.	plication, including the curre on, U.S. Application No. [nt claims, is enclosed], to which priori	
The Extreference	amine	r is requested to return a copy of re considered with the next office	the above list of pending appear communication.	plications indicating	whic
It is req	uested	that the information disclosed h	nerein be made of record in the	nis application.	
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[]	A che	ck for the fee noted above is encapanying Reply. A copy of this S		cluded in the check w	rith t
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Concord, MA 017#2-9133 Dated: 5/21/04

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PTO-1449 REPRODUCED			APPLICATION NO. 10/073,674		
SUPPLEMENTAL INFORMATION DISCLOSURE CITATION IN AN APPLICATION	FIRST NAMED INVENTOR Christina Lampe-Onnerud			хте ry 11, 2002	
MAY 2 4 2004 (See several sheets if necessary)	EXAMINER Hoa Van Le	CONFI 4577	RMATION NO.	GROUP 1752	
13.					

	TRADEN	U.S. PA	ATENT DOCUMENTS	
EXAM INER INI- TIAL	REF. NO.	DOCUMENT NUMBER Number-Kind Code (if known)	ISSUE DATE / PUBLICATION DATE MM-DD-YYYY	NAME OF PATENTEE OR APPLICANT OF CITED DOCUMENT
	AA	6,274,272 B1	08/14/2001	Peres et al.

FOREIGN PATENT DOCUMENTS					
	DOCUMENT NUMBER Country Code-Number-Kind Code (if known) DATE MM-DD-YYYY NAME OF PATENTEE OR APPLICANT OF CITED DOCUMENT		TRANS YES	TRANSLATION YES NO	
AP3	JP 11-92149	04-06-1999	FMC Corp		X
AQ3	JP 08-315819 (abstract only)	11-29-1996	Yuasa Corporation		X
AL4	JP 11-40153	02-12-1999	Hitachi Ltd.		X
AM4	JP 10-208743	08-07-1998	Hitachi Ltd.		X
AN4	JP 10-241691	09-11-1998	Hitachi Ltd.		X
AO4	EP 0 993 057 A1	04-12-2000	Alcatel		X
AP4					

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)						
AR	Chowdari, B.V.R., et al., "Cathodic behavior of (Co, Ti, Mg)-doped LiNiO ₂ " Solid State Ionics, 140:55-62 (2001).					
AS	Sun, X., et al., "Studies on Relationship Between Structure of Over-charge State and Thermal Stability for LiNiO ₂ Based Cathode Materials," <i>Electrochemical Society Proceedings</i> , 99(25):268-277 (2000)					
AT						
AU						
AV						
AW						

EXAMINER	DATE CONSIDERED
<u> </u>	